

<b>Notice of References Cited</b>	Application/Control No. 09/835,620	Applicant(s)/Patent Under Reexamination TAKASHIMIZU, YOSHIHIRO	
	Examiner Lucas Divine	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	American Heritage College Dictionary, Fourth Edition, 2002, Houghton Mifflin Company, page1376
	V	The Authoritative Dictionary of IEEE Standards Terms, Seventh Edition, 2000, IEEE, page 1122
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